


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517375	<b>Applicant(s)/Patent Under Reexamination</b>  HANADA ET AL.
	<b>Examiner</b>  Palenik, Jeffrey T	<b>Art Unit</b>  1615

SEARCHED			
Class	Subclass	Date	Examiner
424	70	29 Oct. 2007	JTP
A61K	7/075	29 Oct. 2007	JTP
A61K	No classified search performed.	4/20/2009	JTP
424	No classified search performed.	4/20/2009	JTP
106	No classified search performed.	4/20/2009	JTP
510	No classified search performed.	4/20/2009	JTP

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search	29 Oct. 2007	JTP
EAST search	29 Oct. 2007	JTP
Google search	29 Oct. 2007	JTP
STIC translation (JP 9-151119)	29 Oct. 2007	JTP
STIC translation (JP 2002-179535)	30 Oct. 2007	JTP
Inventor search updated in PALM (eDAN) and EAST	4/20/2009	JTP
EAST search (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB) see attached history for terms of record searched.	4/20/2009	JTP
STIC manual translation for submitted Japanese patents	4/20/2009	JTP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/ Jeffrey T Palenik/ Examiner, Art Unit 1615	
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